Form 1449 (Modified)	Atty Docket No.	101-P291/P3157US1
	Application No.:	10/687,534
Information Disclosure	Applicant	Kondrk et al.
Statement By Applicant	Filing Date	10/15/03
	Group	3627
(Use Several Sheets if Necessary)	Confirmation No.	7744

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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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